



# 700V Super-Junction Power MOSFET

## FEATURES

- Very low FOM  $R_{DS(on)} \times Q_g$
- 100% avalanche tested
- RoHS compliant



## APPLICATIONS

- Switch Mode Power Supply (SMPS)
- Uninterruptible Power Supply (UPS)
- Power Factor Correction (PFC)

Device Marking and Package Information				
Device	TPA70R360M	TPD70R360M	TPP70R360M	TPU70R360M
Package	TO-220F	TO-252	TO-220	TO-251
Marking	70R360M	70R360M	70R360M	70R360M

## Absolute Maximum Ratings $T_C = 25^\circ\text{C}$ , unless otherwise noted

Parameter	Symbol	Value		Unit
		TO-252, TO-220, TO-251	TO-220F	
Drain-Source Voltage ( $V_{GS} = 0\text{V}$ )	$V_{DSS}$	700		V
Continuous Drain Current	$I_D$	11		A
		6.6		
Pulsed Drain Current (note1)	$I_{DM}$	33		A
Gate-Source Voltage	$V_{GSS}$	$\pm 30$		V
Single Pulse Avalanche Energy (note2)	$E_{AS}$	215		mJ
Avalanche Current (note1)	$I_{AR}$	1.8		A
Repetitive Avalanche Energy (note1)	$E_{AR}$	0.32		mJ
MOSFET dv/dt ruggedness, $V_{DS} = 0\ldots 480\text{V}$	dv/dt	50		V/ns
Reverse diode dv/dt, $V_{DS} = 0\ldots 480\text{V}$ , $I_{SD} \leq I_b$	dv/dt	15		V/ns
Power Dissipation ( $T_C = 25^\circ\text{C}$ )	$P_D$	83	31	W
Operating Junction and Storage Temperature Range	$T_J, T_{stg}$	-55~+150		°C

## Thermal Resistance

Parameter	Symbol	Value		Unit
		TO-252, TO-220, TO-251	TO-220F	
Thermal Resistance, Junction-to-Case	$R_{thJC}$	1.5	4	
Thermal Resistance, Junction-to-Ambient	$R_{thJA}$	62	80	°C/W

**Specifications**  $T_J = 25^\circ\text{C}$ , unless otherwise noted

Parameter	Symbol	Test Conditions	Value			Unit
			Min.	Typ.	Max.	
<b>Static</b>						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$	700	--	--	V
Zero Gate Voltage Drain Current	$I_{\text{DSS}}$	$V_{\text{DS}} = 700\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 25^\circ\text{C}$	--	--	1	$\mu\text{A}$
		$V_{\text{DS}} = 700\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 150^\circ\text{C}$	--	--	100	
Gate-Source Leakage	$I_{\text{GSS}}$	$V_{\text{GS}} = \pm 30\text{V}$	--	--	$\pm 100$	nA
Gate-Source Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$	2.5	--	4.5	V
Drain-Source On-Resistance (Note3)	$R_{\text{DS}(\text{on})}$	$V_{\text{GS}} = 10\text{V}, I_D = 5.5\text{A}$	--	0.31	0.36	$\Omega$
Gate resistance	$R_G$	f = 1.0MHz open drain	--	18	--	$\Omega$
<b>Dynamic</b>						
Input Capacitance	$C_{\text{iss}}$	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 100\text{V}, f = 1.0\text{MHz}$	--	871	--	$\text{pF}$
Output Capacitance	$C_{\text{oss}}$		--	37	--	
Reverse Transfer Capacitance	$C_{\text{rss}}$		--	5	--	
Total Gate Charge	$Q_g$	$V_{\text{DD}} = 520\text{V}, I_D = 11\text{A}, V_{\text{GS}} = 10\text{V}$	--	22	--	$\text{nC}$
Gate-Source Charge	$Q_{\text{gs}}$		--	4	--	
Gate-Drain Charge	$Q_{\text{gd}}$		--	8	--	
Turn-on Delay Time	$t_{\text{d}(\text{on})}$	$V_{\text{DD}} = 400\text{V}, I_D = 11\text{A}, R_G = 25\Omega$	--	69.7	--	$\text{ns}$
Turn-on Rise Time	$t_r$		--	69.5	--	
Turn-off Delay Time	$t_{\text{d}(\text{off})}$		--	145	--	
Turn-off Fall Time	$t_f$		--	59	--	
<b>Drain-Source Body Diode Characteristics</b>						
Continuous Body Diode Current	$I_S$	$T_C = 25^\circ\text{C}$	--	--	11	$\text{A}$
Pulsed Diode Forward Current	$I_{\text{SM}}$		--	--	33	
Body Diode Voltage	$V_{\text{SD}}$	$T_J = 25^\circ\text{C}, I_{\text{SD}} = 11\text{A}, V_{\text{GS}} = 0\text{V}$	--	0.9	1.2	V
Reverse Recovery Time	$t_{\text{rr}}$	$V_R = 400\text{V}, I_F = I_S, \frac{dI_F}{dt} = 100\text{A}/\mu\text{s}$	--	377	--	$\text{ns}$
Reverse Recovery Charge	$Q_{\text{rr}}$		--	3.4	--	
Peak Reverse Recovery Current	$I_{\text{rrm}}$		--	17.8	--	$\mu\text{C}$

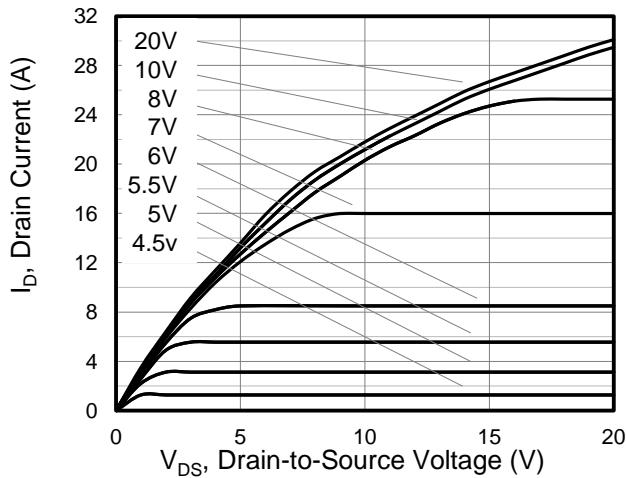
**Notes**

1. Repetitive Rating: Pulse Width limited by maximum junction temperature
2.  $I_{AS} = 1.8\text{A}, V_{DD} = 50\text{V}, R_G = 25\Omega$ , Starting  $T_J = 25^\circ\text{C}$
3. Pulse Test: Pulse Width  $\leq 300\mu\text{s}$ , Duty Cycle  $\leq 1\%$

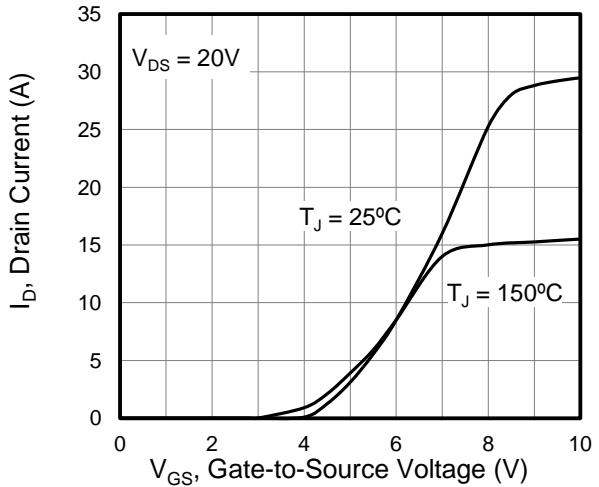


**Typical Characteristics**  $T_J = 25^\circ\text{C}$ , unless otherwise noted

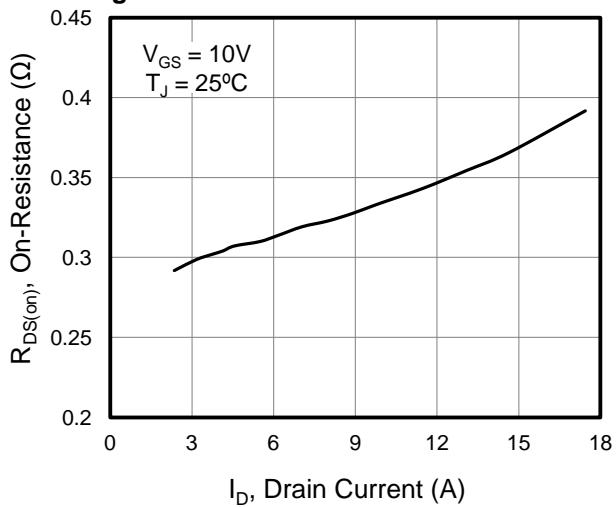
**Figure 1. Output Characteristics**



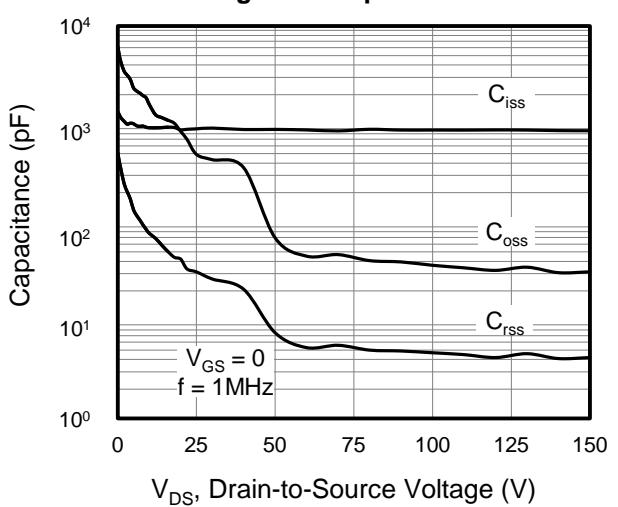
**Figure 2. Transfer Characteristics**



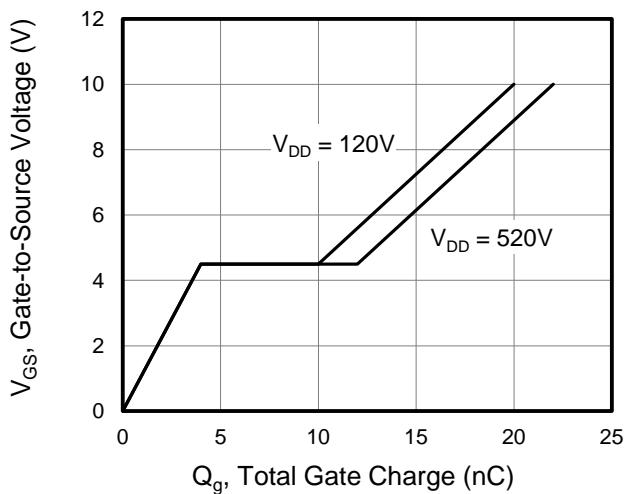
**Figure 3. On-Resistance vs. Drain Current**



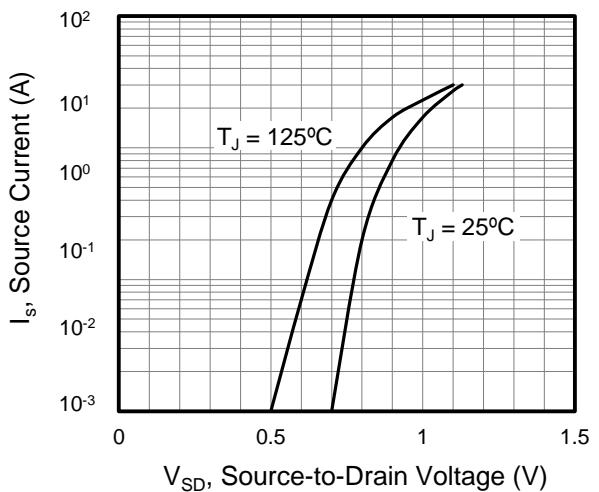
**Figure 4. Capacitance**



**Figure 5. Gate Charge**



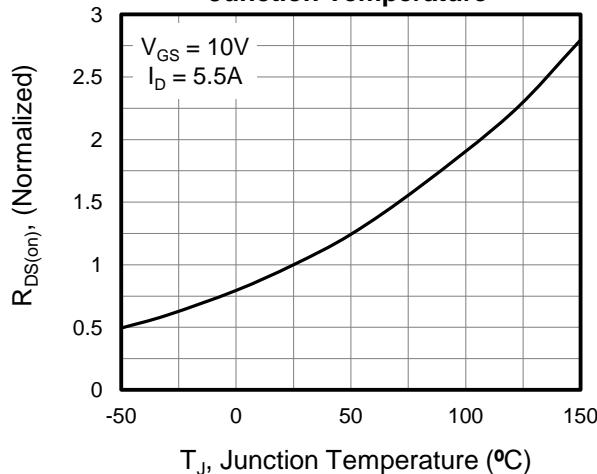
**Figure 6. Body Diode Forward Voltage**



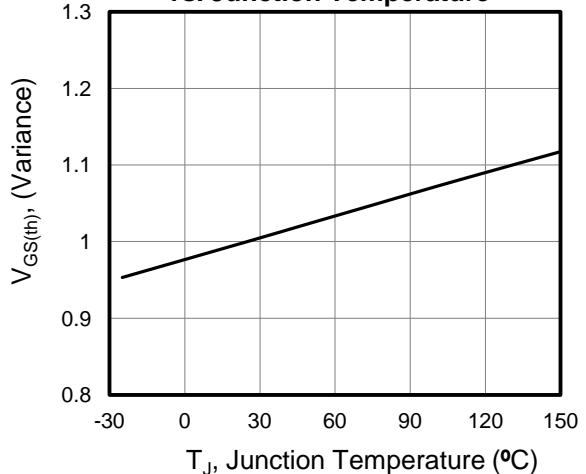


**Typical Characteristics**  $T_J = 25^\circ\text{C}$ , unless otherwise noted

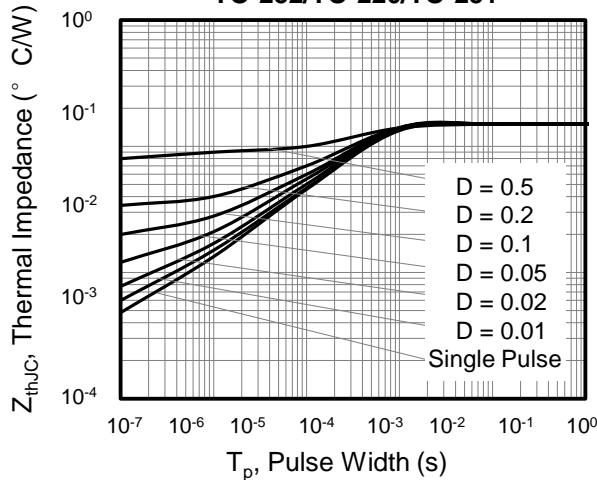
**Figure 7. On-Resistance vs. Junction Temperature**



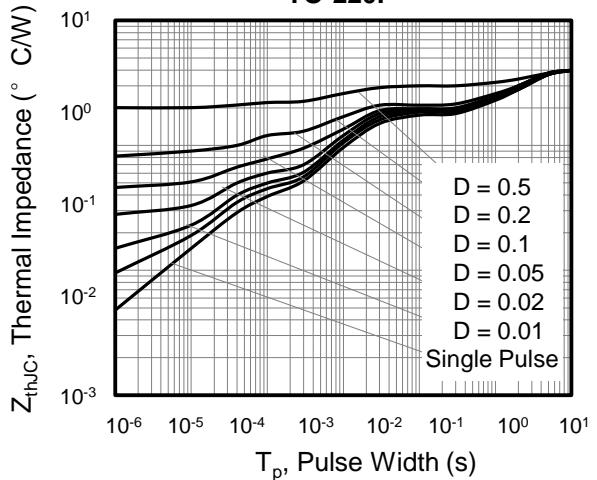
**Figure 8. Breakdown voltage vs. Junction Temperature**



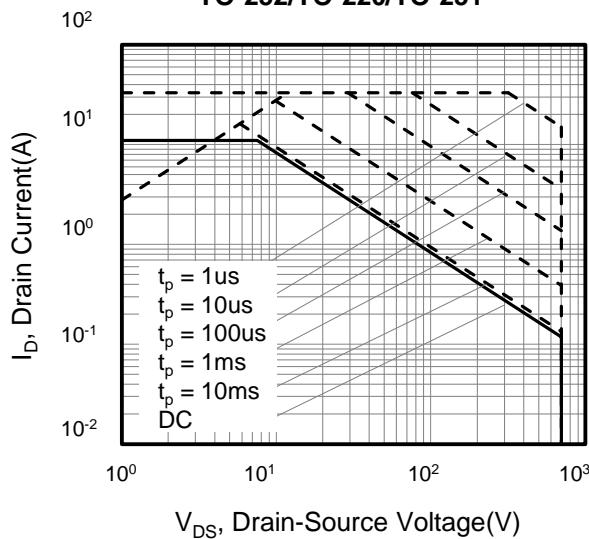
**Figure 9. Transient Thermal Impedance TO-252/TO-220/TO-251**



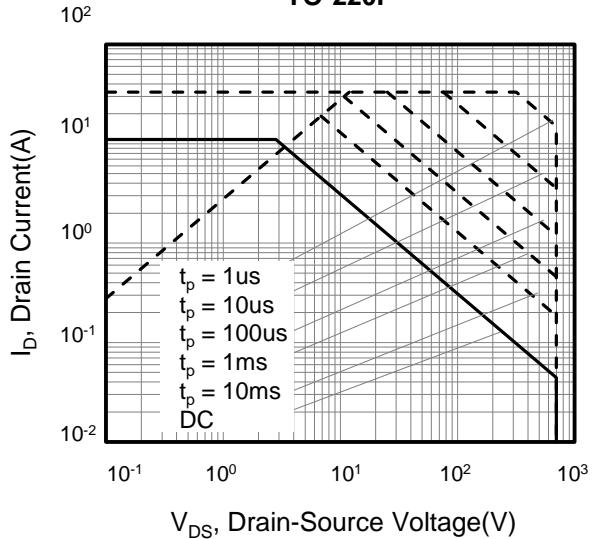
**Figure 10. Transient Thermal Impedance TO-220F**

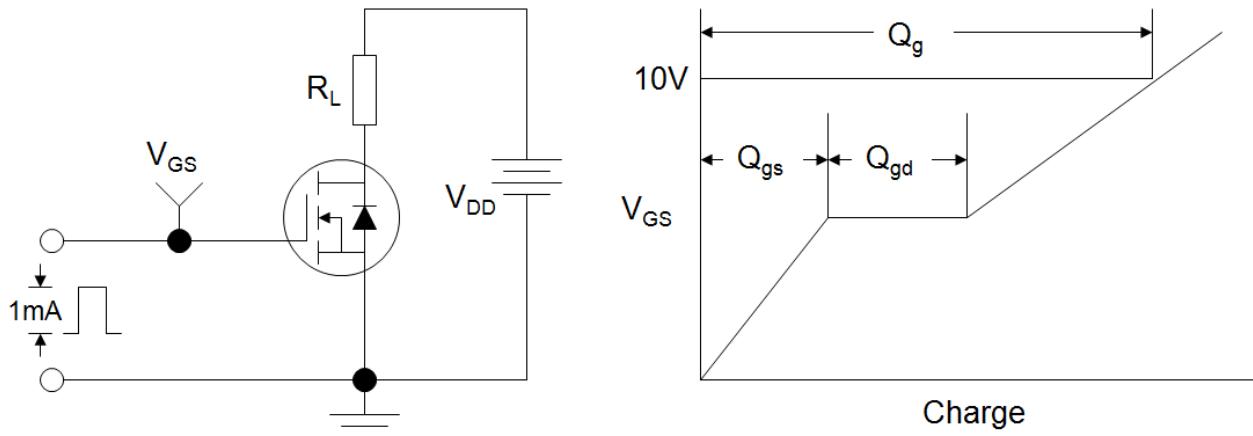
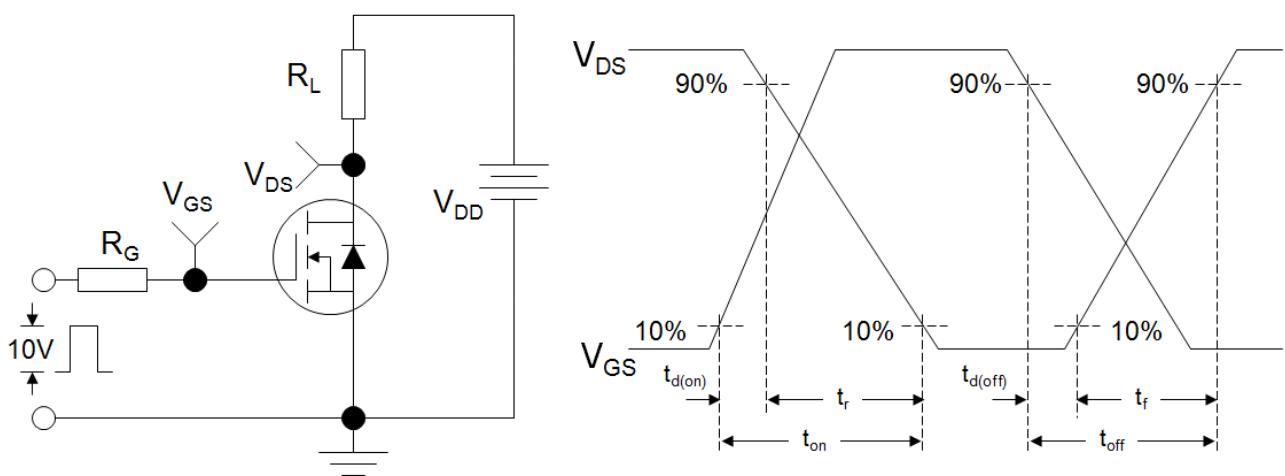
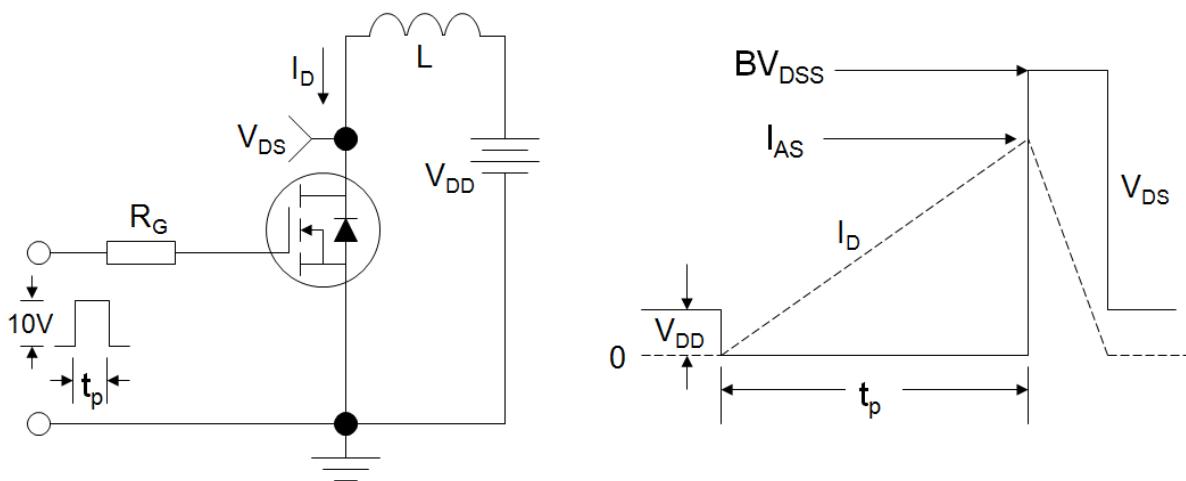


**Figure 11. Safe operation area for TO-252/TO-220/TO-251**



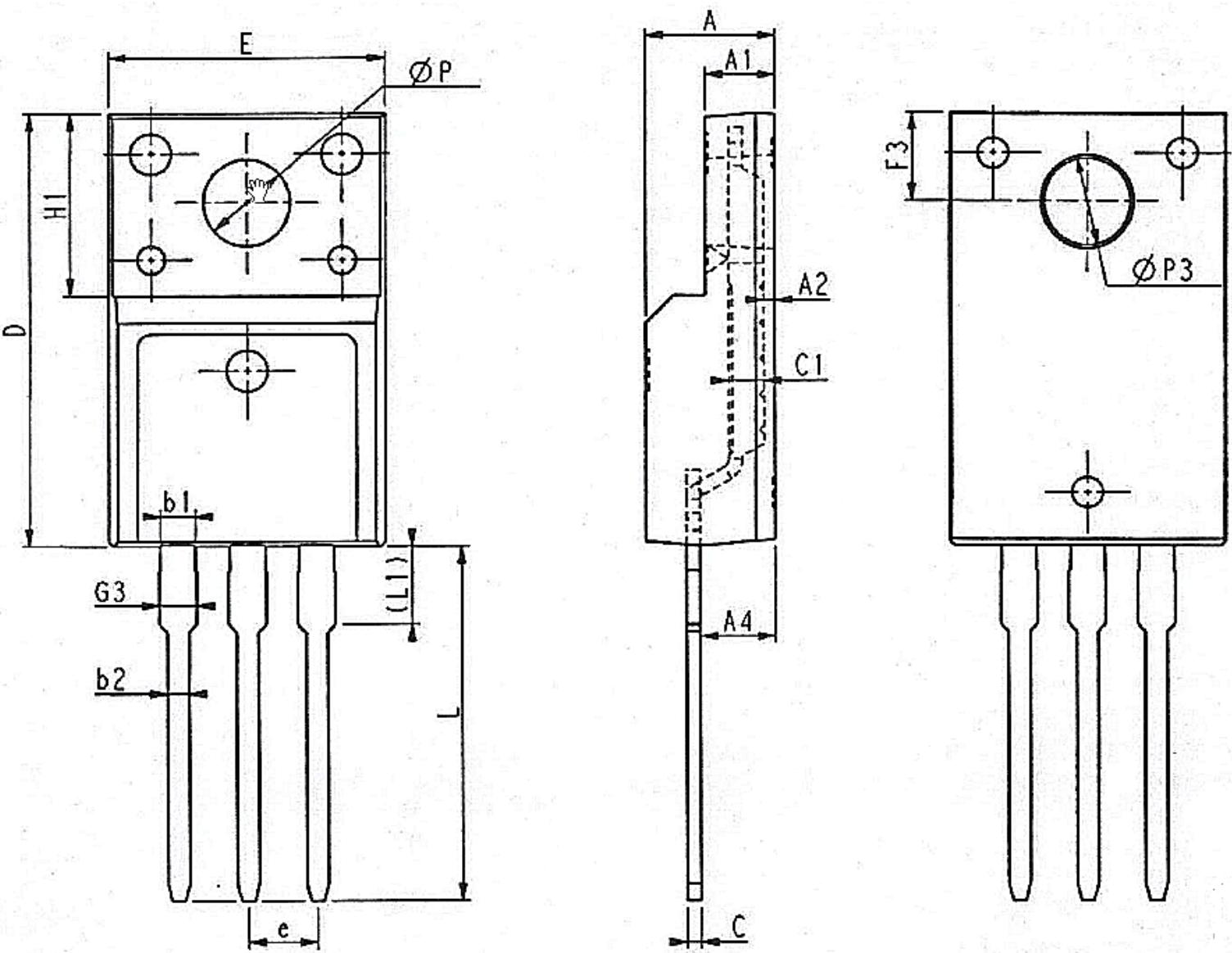
**Figure 12. Safe operation area for TO-220F**



**Figure A: Gate Charge Test Circuit and Waveform**

**Figure B: Resistive Switching Test Circuit and Waveform**

**Figure C: Unclamped Inductive Switching Test Circuit and Waveform**




## TO-220F

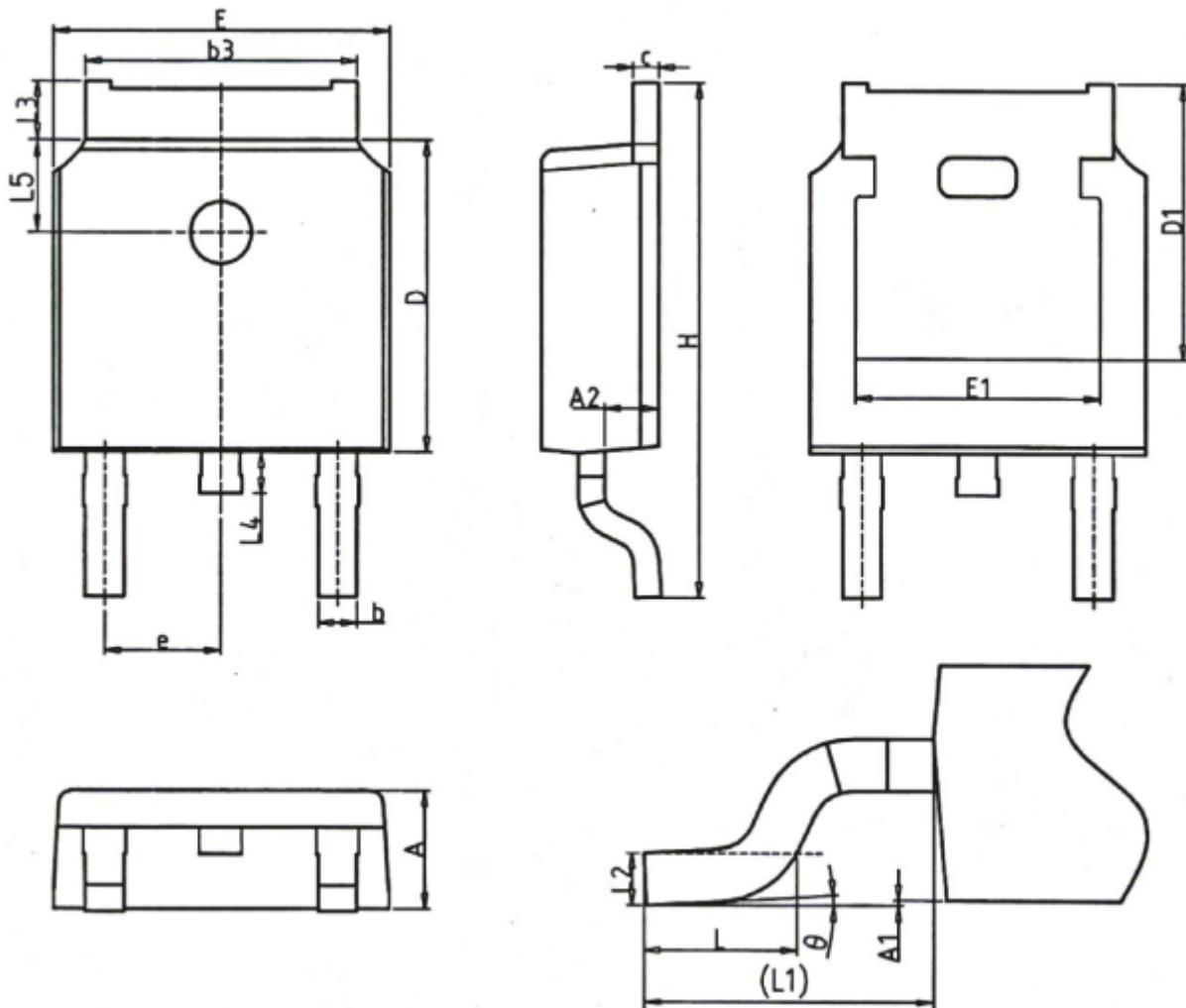


Symbol	Min.	Nom	Max.
E	9.96	10.16	10.36
A	4.50	4.70	4.90
A1	2.34	2.54	2.74
A2	0.30	0.45	0.60
A4	2.56	2.76	2.96
c	0.40	0.50	0.65
c1	1.20	1.30	1.35
D	15.57	15.87	16.17
H1	6.70REF		

Symbol	Min.	Nom	Max.
e	2.54BSC		
L	12.68	12.98	13.28
L1	2.88	3.03	3.18
φP	3.03	3.18	3.38
φP3	3.15	3.45	3.65
F3	3.15	3.30	3.45
G3	1.25	1.35	1.55
b1	1.18	1.28	1.43
b2	0.70	0.80	0.95



## TO-252

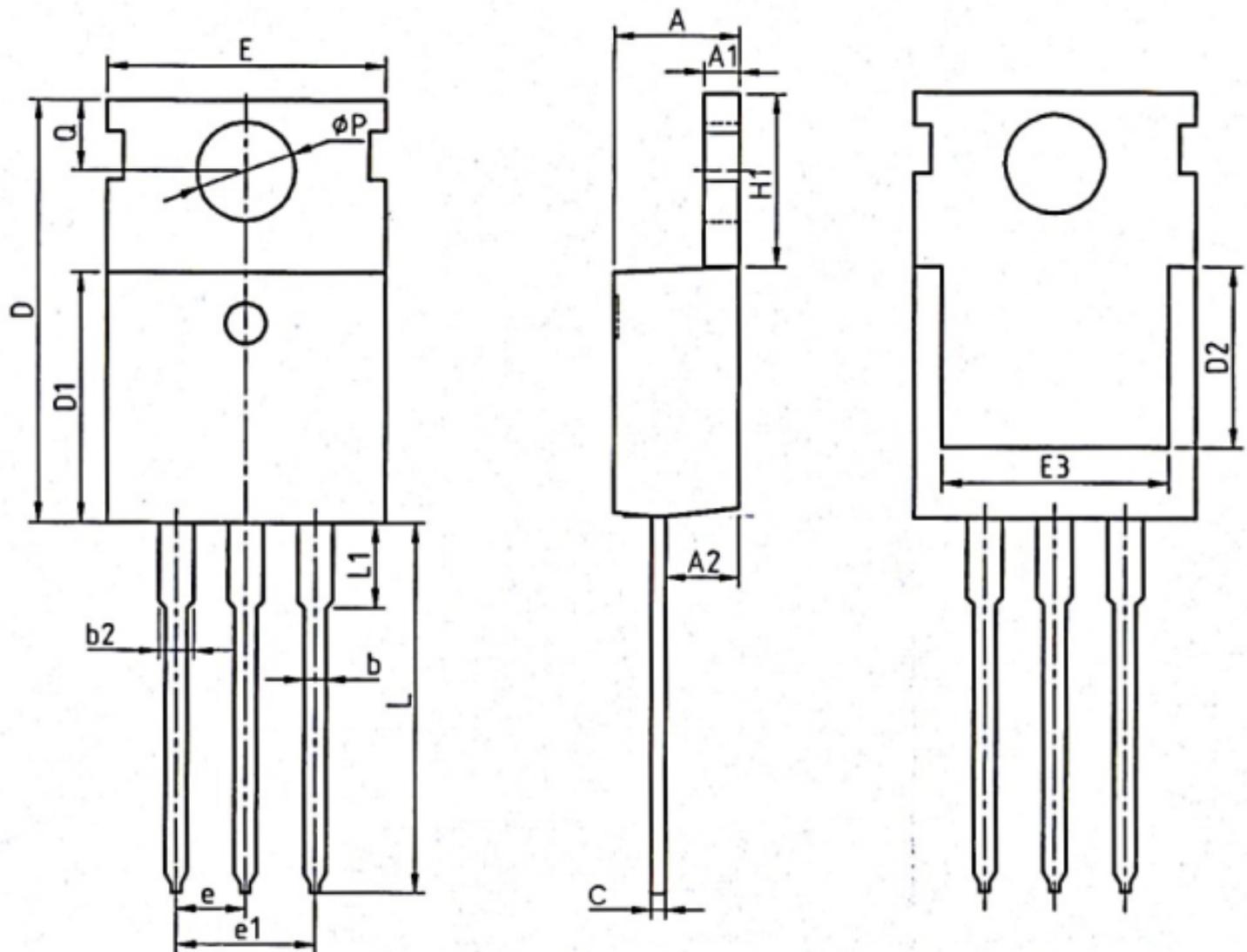


Unit:mm			
Symbol	Min.	Nom	Max.
A	2.20	2.30	2.40
A1	0.00	-	0.20
A2	0.97	1.07	1.17
b	0.68	0.78	0.90
b3	5.20	5.33	5.50
c	0.43	0.53	0.63
D	5.98	6.10	6.22
D1	5.30 REF		
E	6.40	6.60	6.80
E1	4.63	-	-

Unit:mm			
Symbol	Min.	Nom	Max.
e	2.286 BSC		
H	9.40	10.10	10.50
L	1.38	1.50	1.75
L1	2.90 REF		
L2	0.51 BSC		
L3	0.88	-	1.28
L4	-	-	1.00
L5	1.65	1.80	1.95
θ	0°	-	8°



## TO-220

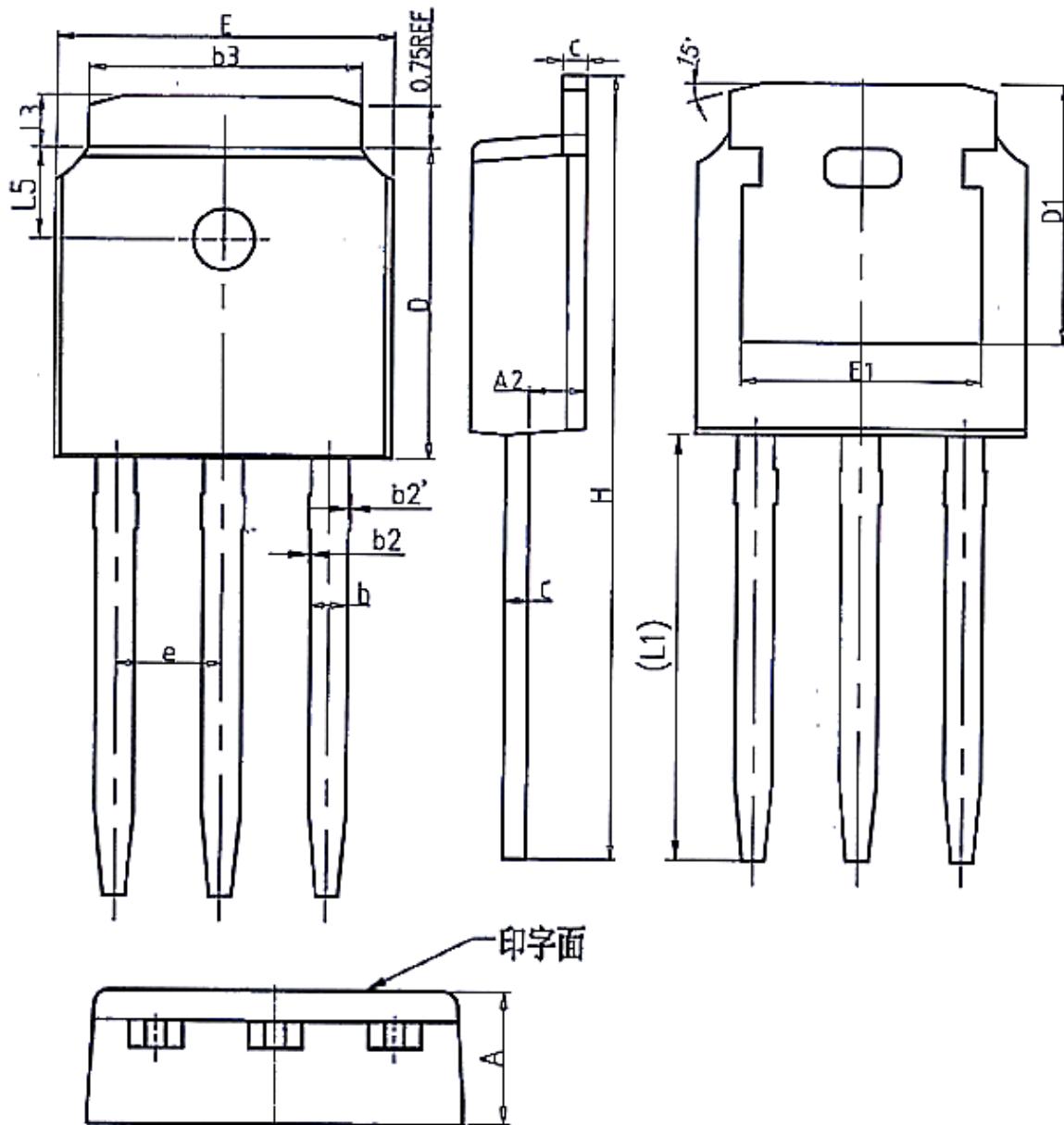


Unit:mm			
Symbol	Min.	Nom	Max.
A	4.37	4.57	4.77
A1	1.25	1.30	1.45
b	2.20	2.40	2.60
b2	1.17	1.27	1.47
c	0.45	0.50	0.60
D	15.10	15.60	16.10
D1	8.80	9.10	9.40
D2	5.50	-	-
E	9.70	10.00	10.30

Unit:mm			
Symbol	Min.	Nom	Max.
E3	7.00	-	-
e	2.54BSC		
e1	5.08BSC		
H1	6.25	6.50	6.85
L	12.75	13.50	13.80
L1	-	3.10	3.40
ΦP	3.40	3.60	3.80
Q	2.60	2.80	3.00



## TO-251



Unit:mm			
Symbol	Min.	Nom	Max.
A	2.20	2.30	2.40
A2	0.97	1.07	1.17
b	0.68	0.78	0.90
b2'	0.00	0.04	0.10
b3	5.20	5.33	5.50
c	0.43	0.53	0.63
D	5.98	6.10	6.22

Unit:mm			
Symbol	Min.	Nom	Max.
D1		5.30 REF	
E	6.40	6.60	6.80
E1	4.63	-	-
e	2.286 BSC		
H	16.22	16.52	16.82
L1	9.15	9.40	9.65
L3	0.88	1.02	1.28
L5	1.65	1.80	1.95



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